

FDH3632-VB Datasheet

N-Channel 100 V (D-S) 175 °C MOSFET

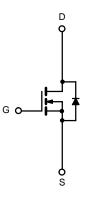
PRODUCT SUMMARY				
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)		
100	0.006 at V _{GS} = 10 V	150		

FEATURES

- TrenchFET[®] Power MOSFET
- New Package with Low Thermal Resistance
- 100 % R_g Tested







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted					
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	100	M		
Gate-Source Voltage	V _{GS}	± 20	V		
Continuous Dusin Oursent (T. 475 °C)	T _C = 25 °C		150		
Continuous Drain Current ($T_J = 175 \text{ °C}$)	T _C = 125 °C		100 ^a		
Pulsed Drain Current	I _{DM}	600	- A		
Avalanche Current	I _{AR}	75			
Repetitive Avalanche Energy ^b	L = 0.1 mH	E _{AR}	280	mJ	
Maximum Power Dissipation ^b	T _C = 25 °C	Б	375 ^c	w	
	T _A = 25 °C	– P _D –	3.75		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Limit	Unit	
Junction-to-Ambient	TO-247	R _{thJA}	40	°C/W	
Junction-to-Case (Drain)		R _{thJC}	0.5	C/VV	

Notes:

a. Package limited.

b. Duty cycle \leq 1 %. c. See SOA curve for voltage derating.

SPECIFICATIONS T _J = 25 °C, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	$V_{DS} = 0 V, I_{D} = 250 \mu A$	100			- V
Gate-Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2		4	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
		V _{DS} = 100 V, V _{GS} = 0 V			1	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 ^{\circ}\text{C}$			50	μA
		$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 175 ^{\circ}\text{C}$			250	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	120			А
		V _{GS} = 10 V, I _D = 30 A		0.006		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 30 A, T _J = 125 °C		0.017		Ω
		V _{GS} = 10 V, I _D = 30 A, T _J = 175 °C		0.025		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 30 A	25			S
Dynamic ^b	-					
Input Capacitance	C _{iss}			6700		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1 MHz		750		
Reverse Transfer Capacitance	C _{rss}			280		
Total Gate Charge ^c	Qg			110	160	nC
Gate-Source Charge ^c	Q _{gs}	$V_{DS} = 50 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 85 \text{ A}$		24		
Gate-Drain Charge ^c	Q _{gd}			24		
Gate Resistance	R _g		1.0		6.2	Ω
Turn-On Delay Time ^c	t _{d(on)}			20	30	
Rise Time ^c	t _r	$V_{DD} = 50 \text{ V, } \text{R}_{\text{L}} = 0.6 \Omega$ $\text{I}_{\text{D}} \cong 85 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V, } \text{R}_{\text{g}} = 2.5 \Omega$		125	200	ns
Turn-Off Delay Time ^c	t _{d(off)}			55	85	
Fall Time ^c	t _f			130	195	
Source-Drain Diode Ratings and Cha	aracteristics	$\Gamma_{\rm C} = 25 {}^{\circ}{\rm C}^{\rm b}$				
Continuous Current	۱ _S				110	- A
Pulsed Current	I _{SM}				240	
Forward Voltage ^a	V _{SD}	I _F = 85 A, V _{GS} = 0 V		1.0	1.5	V
Reverse Recovery Time	t _{rr}			70	140	ns
Peak Reverse Recovery Charge	I _{RM(REC)}	I _F = 50 A, dl/dt = 100 A/μs		5.5	10	А
Reverse Recovery Charge	Q _{rr}]		0.19	0.35	μC

Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

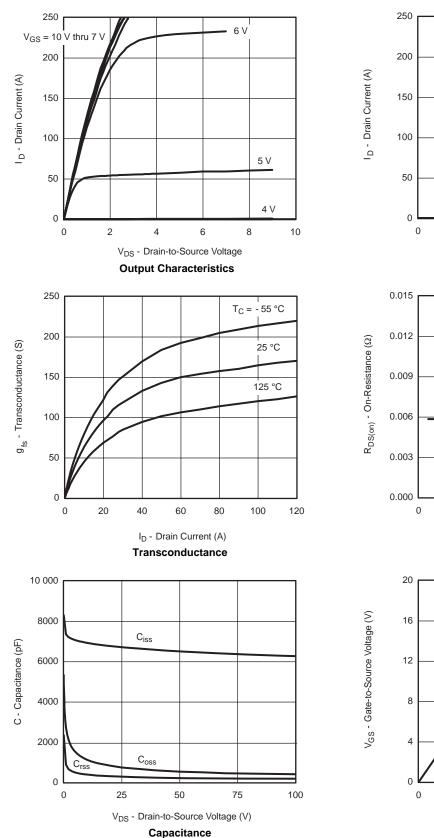
c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

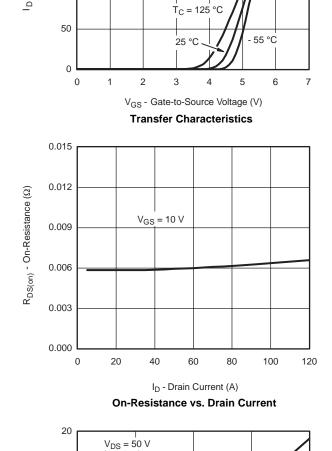
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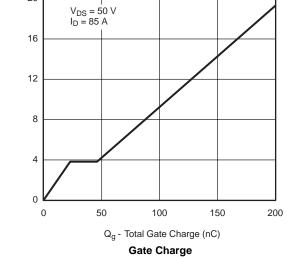
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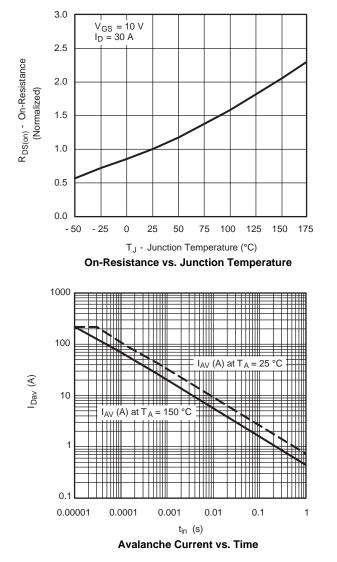
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

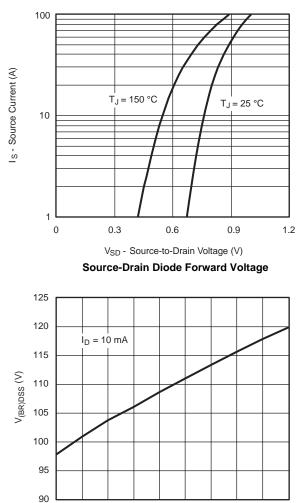






TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





- 50 - 25

0 25 50

75 100 125

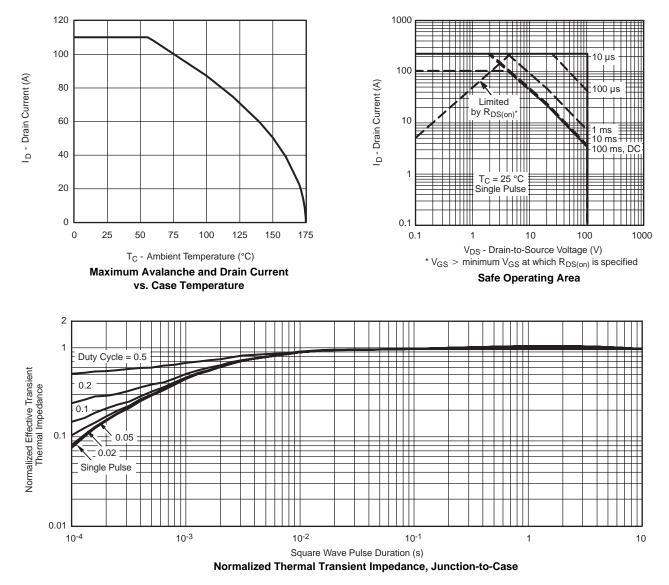
T_J - Junction Temperature (°C)

Drain Source Breakdown vs. Junction Temperature

150 175

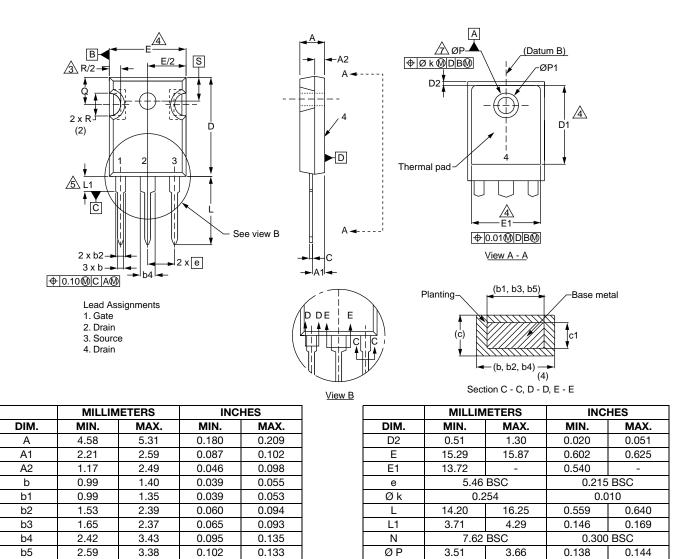


THERMAL RATINGS





TO-247AC



Ø P1

Q R

S

5.31

4.52

0.291

0.224

0.216

7.39

5.69

5.49

5.51 BSC

0.209

0.178

0.217 BSC

0.38

0.38

19.71

13.08

0.86

0.76

20.82

-

0.015

0.015

0.776

0.515

0.034

0.030

0.820

С

с1

D

D1



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